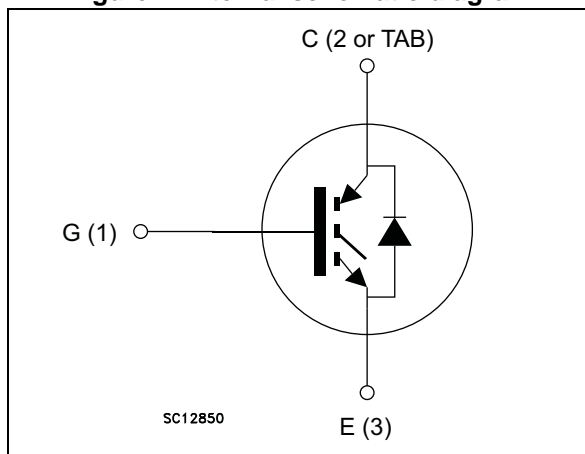


Figure 1. Internal schematic diagram



### Features

- Maximum junction temperature:  $T_J = 175\text{ °C}$
- Tail-less switching off
- $V_{CE(sat)} = 1.85\text{ V (typ.) @ } I_C = 80\text{ A}$
- Tight parameters distribution
- Safe paralleling
- Low thermal resistance
- Very fast soft recovery antiparallel diode

### Applications

- Photovoltaic inverters
- Uninterruptible power supply
- Welding
- Power factor correction
- Very high frequency converters

### Description

This device is an IGBT developed using an advanced proprietary trench gate field stop structure. The device is part of the V series of IGBTs, which represent an optimum compromise between conduction and switching losses to maximize the efficiency of very high frequency converters. Furthermore, a positive  $V_{CE(sat)}$  temperature coefficient and very tight parameter distribution result in safer paralleling operation.

Table 1. Device summary

Order code	Marking	Package	Packaging
STGW80V60DF	GW80V60DF	TO-247	Tube
STGWT80V60DF	GWT80V60DF	TO-3P	Tube

# Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{CES}$	Collector-emitter voltage ( $V_{GE} = 0$ )	600	V
$I_C$	Continuous collector current at $T_C = 25\text{ °C}$	120 <sup>(1)</sup>	A
$I_C$	Continuous collector current at $T_C = 100\text{ °C}$	80	A
$I_{CP}$ <sup>(2)</sup>	Pulsed collector current	240	A
$V_{GE}$	Gate-emitter voltage	$\pm 20$	V
$I_F$	Continuous forward current at $T_C = 25\text{ °C}$	120 <sup>(1)</sup>	A
$I_F$	Continuous forward current at $T_C = 100\text{ °C}$	80	A
$I_{FP}$ <sup>(2)</sup>	Pulsed forward current	360	A
$P_{TOT}$	Total dissipation at $T_C = 25\text{ °C}$	469	W
$T_{STG}$	Storage temperature range	- 55 to 150	°C
$T_J$	Operating junction temperature	- 55 to 175	°C

1. Current level is limited by bond wires
2. Pulse width limited by maximum junction temperature

**Table 3. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thJC}$	Thermal resistance junction-case IGBT	0.32	°C/W
$R_{thJC}$	Thermal resistance junction-case diode	0.66	°C/W
$R_{thJA}$	Thermal resistance junction-ambient	50	°C/W

## 2 Electrical characteristics

$T_J = 25\text{ °C}$  unless otherwise specified.

**Table 4. Static characteristics**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)CES}$	Collector-emitter breakdown voltage ( $V_{GE} = 0$ )	$I_C = 2\text{ mA}$	600			V
$V_{CE(sat)}$	Collector-emitter saturation voltage	$V_{GE} = 15\text{ V}, I_C = 80\text{ A}$		1.85	2.3	V
		$V_{GE} = 15\text{ V}, I_C = 80\text{ A}$ $T_J = 125\text{ °C}$		2.15		
		$V_{GE} = 15\text{ V}, I_C = 80\text{ A}$ $T_J = 175\text{ °C}$		2.4		
$V_F$	Forward on-voltage	$I_F = 80\text{ A}$		1.9	2.3	V
		$I_F = 80\text{ A}, T_J = 125\text{ °C}$		1.6		V
		$I_F = 80\text{ A}, T_J = 175\text{ °C}$		1.5		V
$V_{GE(th)}$	Gate threshold voltage	$V_{CE} = V_{GE}, I_C = 1\text{ mA}$	5	6	7	V
$I_{CES}$	Collector cut-off current ( $V_{GE} = 0$ )	$V_{CE} = 600\text{ V}$			100	$\mu\text{A}$
$I_{GES}$	Gate-emitter leakage current ( $V_{CE} = 0$ )	$V_{GE} = \pm 20\text{ V}$			250	nA

Table 5. Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{ies}$	Input capacitance	$V_{CE} = 25\text{ V}$ , $f = 1\text{ MHz}$ , $V_{GE} = 0$	-	10800	-	nF
$C_{oes}$	Output capacitance		-	390	-	pF
$C_{res}$	Reverse transfer capacitance		-	220	-	pF
$Q_g$	Total gate charge	$V_{CC} = 480\text{ V}$ , $I_C = 80\text{ A}$ , $V_{GE} = 15\text{ V}$ , see <a href="#">Figure 29</a>	-	448	-	nC
$Q_{ge}$	Gate-emitter charge		-	76	-	nC
$Q_{gc}$	Gate-collector charge		-	184	-	nC

Table 6. IGBT switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{CE} = 400\text{ V}$ , $I_C = 80\text{ A}$ , $R_G = 5\ \Omega$ , $V_{GE} = 15\text{ V}$ , see <a href="#">Figure 28</a>	-	60	-	ns
$t_r$	Current rise time		-	30	-	ns
$(di/dt)_{on}$	Turn-on current slope		-	2200	-	A/ $\mu$ s
$t_{d(off)}$	Turn-off delay time		-	220	-	ns
$t_f$	Current fall time		-	17	-	ns
$E_{on}^{(1)}$	Turn-on switching losses		-	1.8	-	mJ
$E_{off}^{(2)}$	Turn-off switching losses		-	1	-	mJ
$E_{ts}$	Total switching losses	-	2.8	-	mJ	
$t_{d(on)}$	Turn-on delay time	$V_{CE} = 400\text{ V}$ , $I_C = 80\text{ A}$ , $R_G = 5\ \Omega$ , $V_{GE} = 15\text{ V}$ , $T_J = 175\text{ }^\circ\text{C}$ , see <a href="#">Figure 28</a>	-	60	-	ns
$t_r$	Current rise time		-	30	-	ns
$(di/dt)_{on}$	Turn-on current slope		-	2100	-	A/ $\mu$ s
$t_{d(off)}$	Turn-off delay time		-	240	-	ns
$t_f$	Current fall time		-	22	-	ns
$E_{on}^{(1)}$	Turn-on switching losses		-	3.8	-	mJ
$E_{off}^{(2)}$	Turn-off switching losses		-	1.25	-	mJ
$E_{ts}$	Total switching losses	-	5.05	-	mJ	

1. Energy losses include reverse recovery of the diode.
2. Turn-off losses include also the tail of the collector current.

**Table 7. Diode switching characteristics (inductive load)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{rr}$	Reverse recovery time	$I_F = 80\text{ A}$ , $V_R = 400\text{ V}$ , $di/dt = 1000\text{ A}/\mu\text{s}$ , $V_{GE} = 15\text{ V}$ , see <a href="#">Figure 28</a>	-	60	-	ns
$Q_{rr}$	Reverse recovery charge		-	112	-	nC
$I_{rrm}$	Reverse recovery current		-	3.6	-	A
$dl_{rr}/dt$	Peak rate of fall of reverse recovery current during $t_b$		-	140	-	$\text{A}/\mu\text{s}$
$E_{rr}$	Reverse recovery energy		-	70	-	$\mu\text{J}$
$t_{rr}$	Reverse recovery time	$I_F = 80\text{ A}$ , $V_R = 400\text{ V}$ , $di/dt = 1000\text{ A}/\mu\text{s}$ , $V_{GE} = 15\text{ V}$ ; $T_J = 175\text{ }^\circ\text{C}$ see <a href="#">Figure 28</a>	-	340	-	ns
$Q_{rr}$	Reverse recovery charge		-	2200	-	nC
$I_{rrm}$	Reverse recovery current		-	13	-	A
$dl_{rr}/dt$	Peak rate of fall of reverse recovery current during $t_b$		-	70	-	$\text{A}/\mu\text{s}$
$E_{rr}$	Reverse recovery energy		-	880	-	$\mu\text{J}$

## 2.1 Electrical characteristics (curves)

Figure 2. Power dissipation vs. case temperature

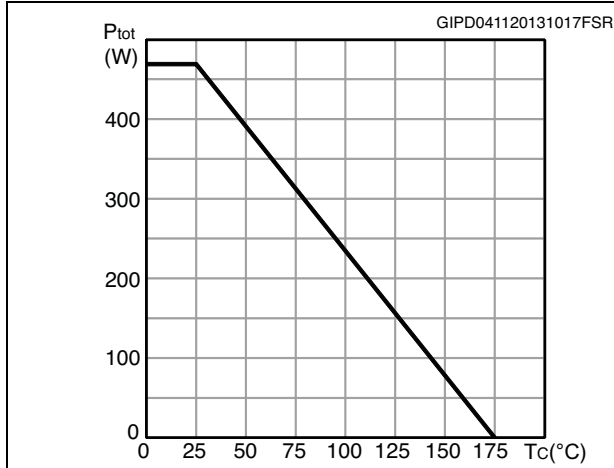


Figure 3. Collector current vs. case temperature

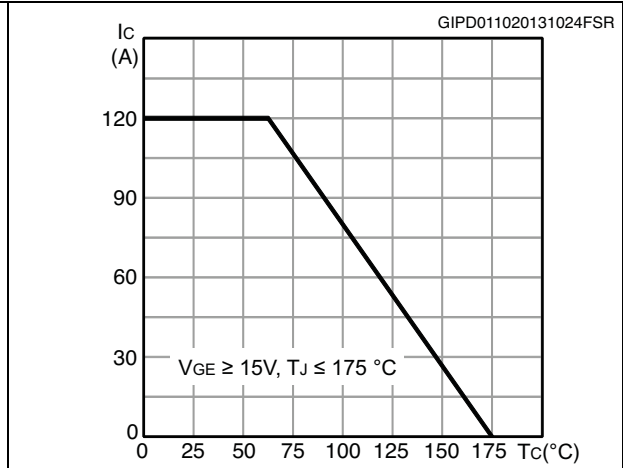


Figure 4. Output characteristics ( $T_J = 25^\circ C$ )

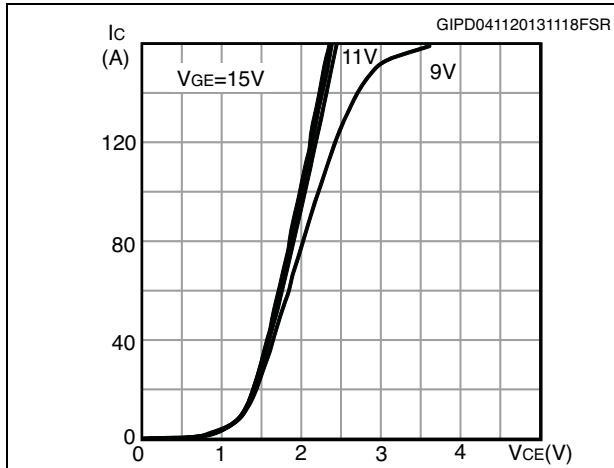


Figure 5. Output characteristics ( $T_J = 175^\circ C$ )

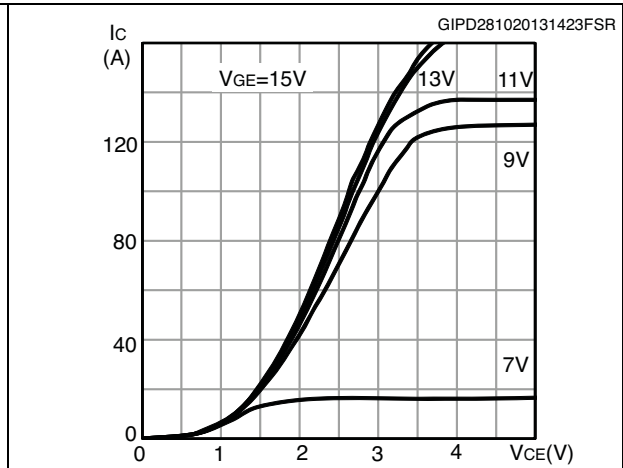


Figure 6.  $V_{CE(sat)}$  vs. junction temperature

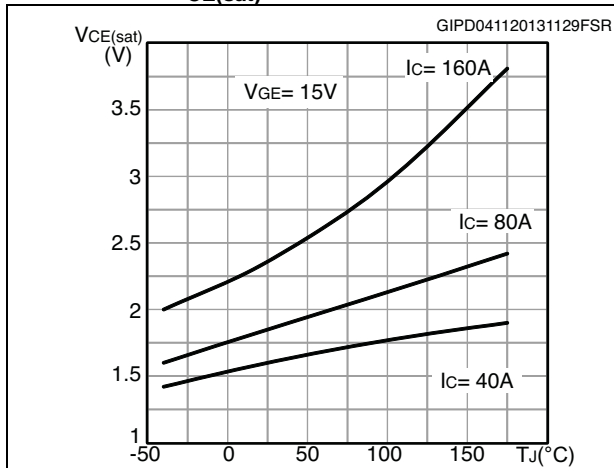


Figure 7.  $V_{CE(sat)}$  vs. collector current

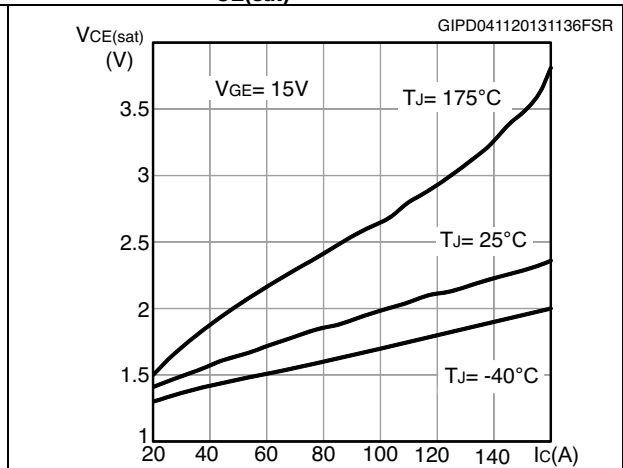


Figure 8. Collector current vs. switching frequency

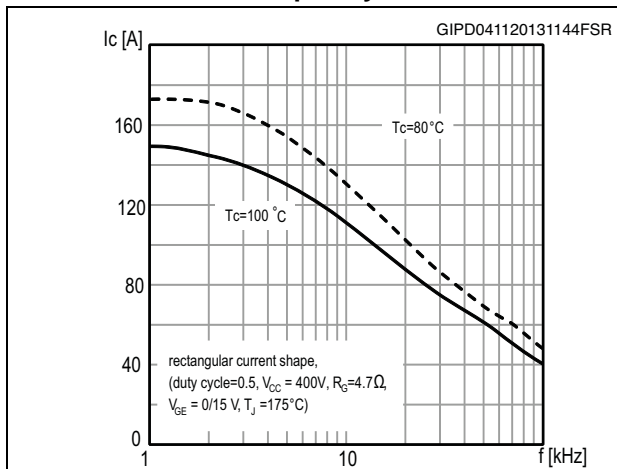


Figure 9. Forward bias safe operating area

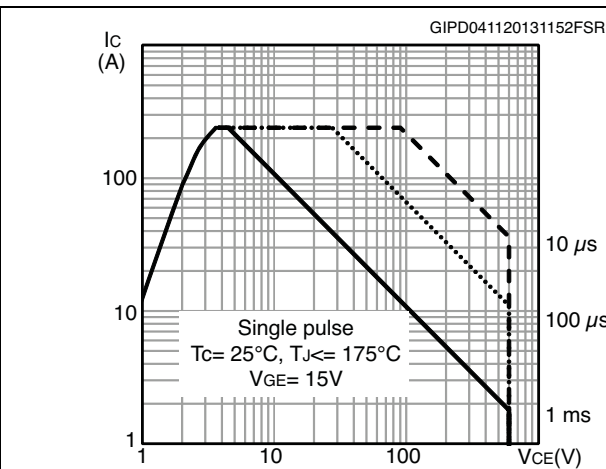


Figure 10. Transfer characteristics

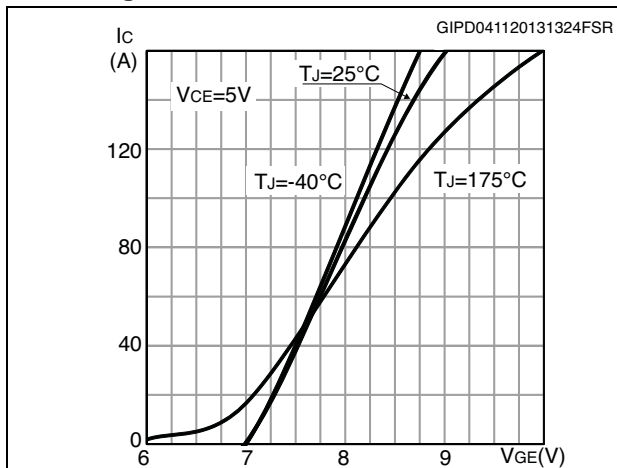


Figure 11. Diode VF vs. forward current

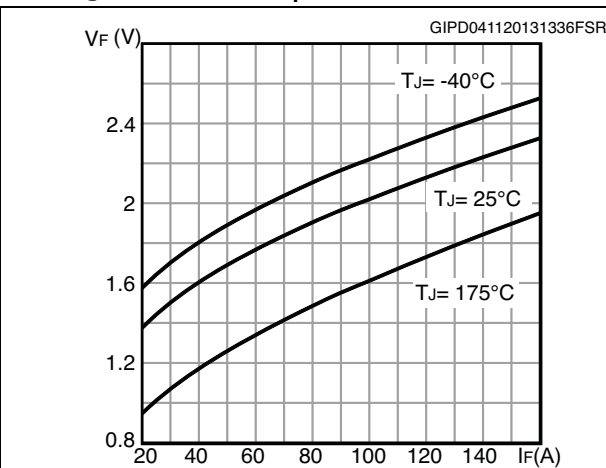


Figure 12. Normalized VGE(th) vs junction temperature

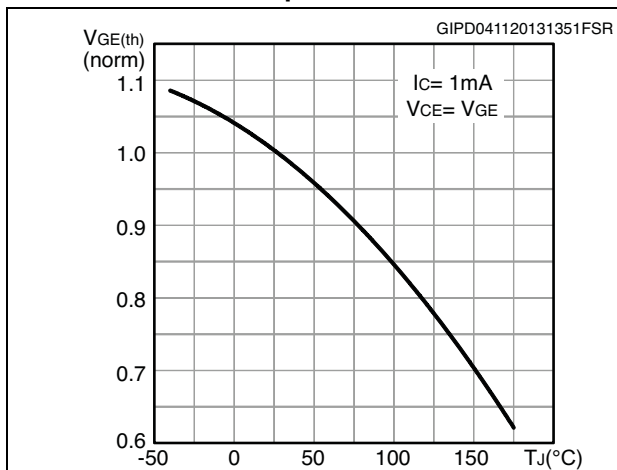


Figure 13. Normalized V(BR)CES vs. junction temperature

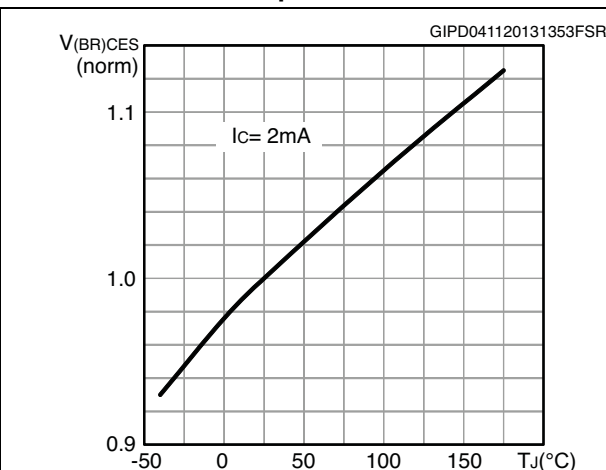


Figure 14. Capacitance variation

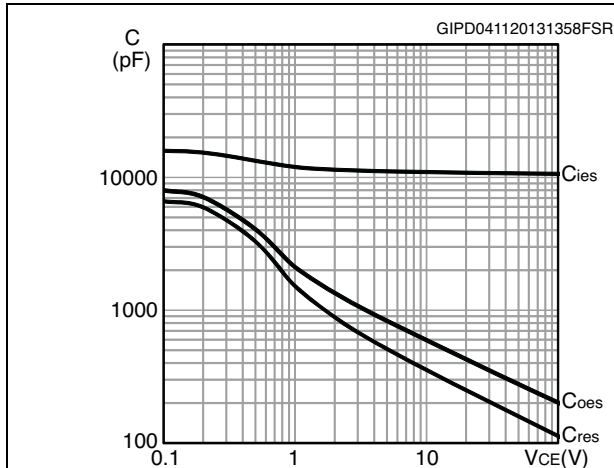


Figure 15. Gate charge vs. gate-emitter voltage

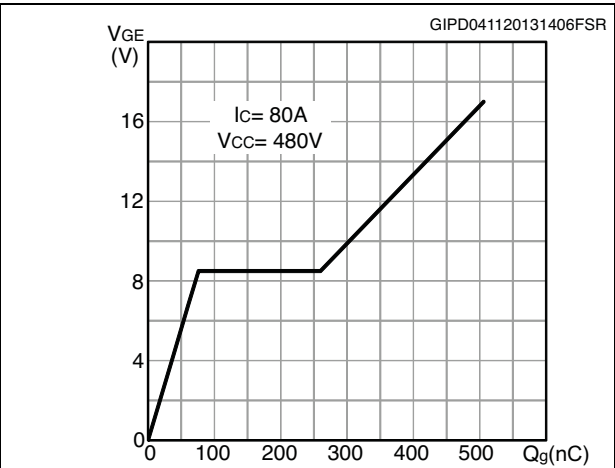


Figure 16. Switching loss vs collector current

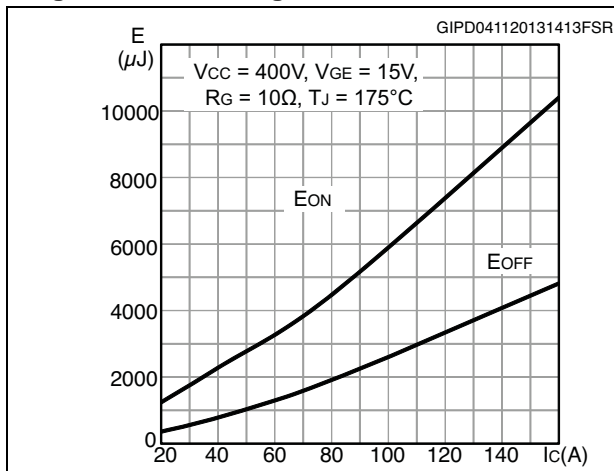


Figure 17. Switching loss vs gate resistance

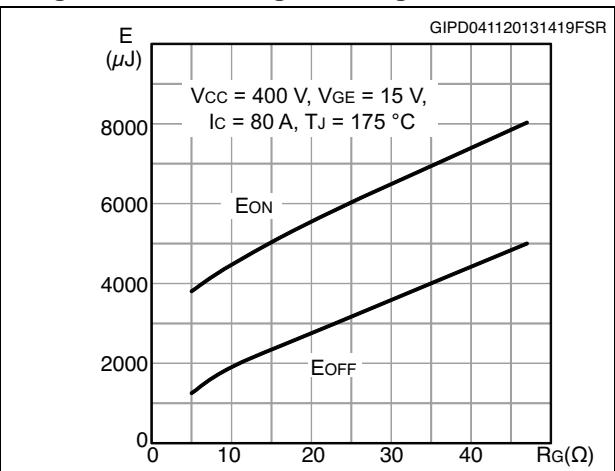


Figure 18. Switching loss vs temperature

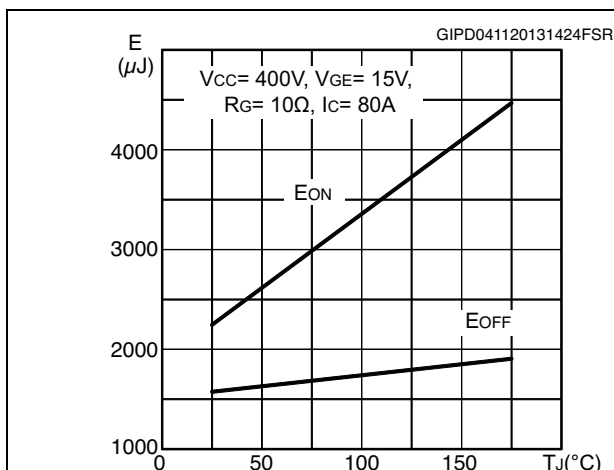


Figure 19. Switching loss vs collector-emitter voltage

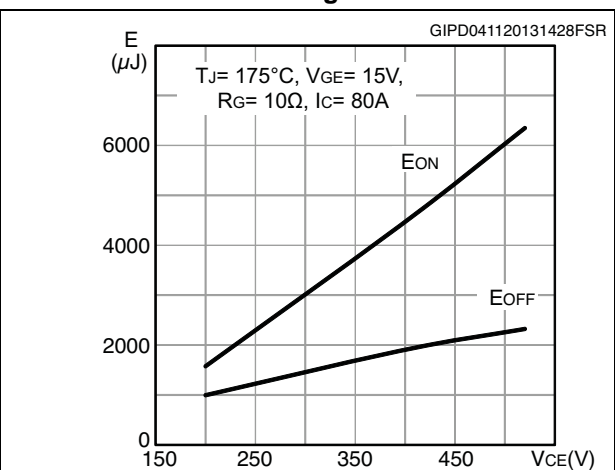


Figure 20. Switching times vs. collector current

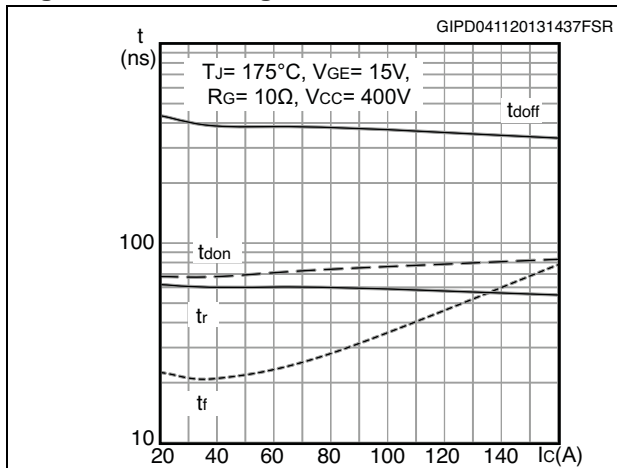


Figure 21. Switching times vs. gate resistance

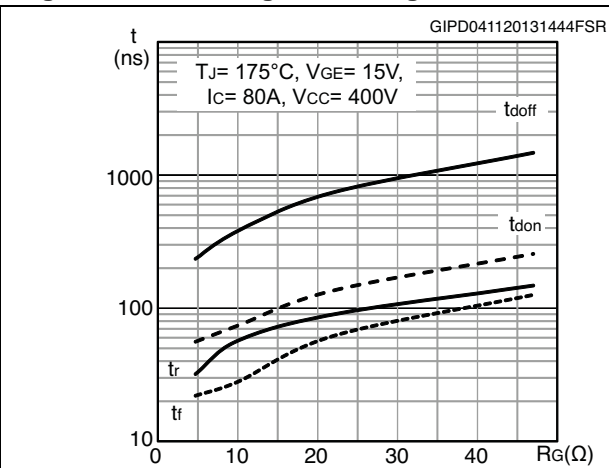


Figure 22. Reverse recovery current vs. diode current slope

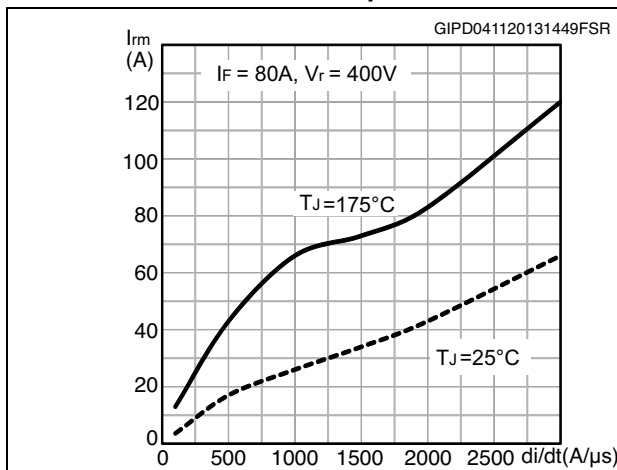


Figure 23. Reverse recovery time vs. diode current slope

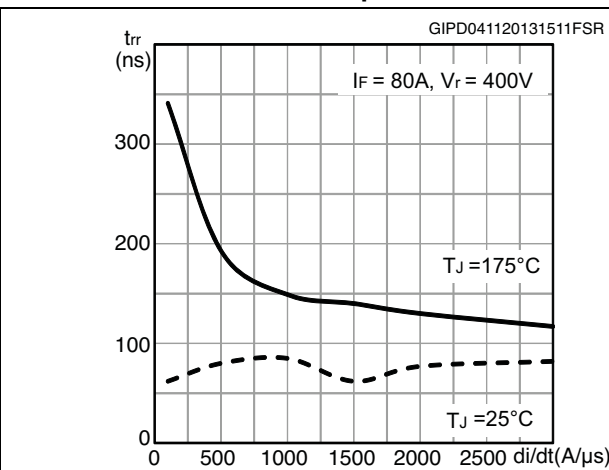


Figure 24. Reverse recovery charge vs. diode current slope

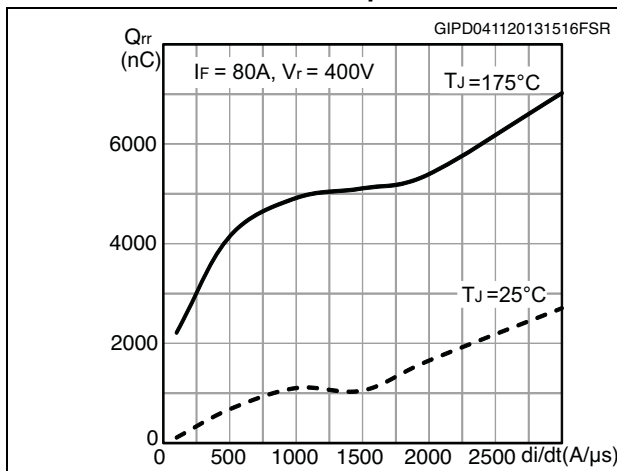


Figure 25. Reverse recovery energy vs. diode current slope

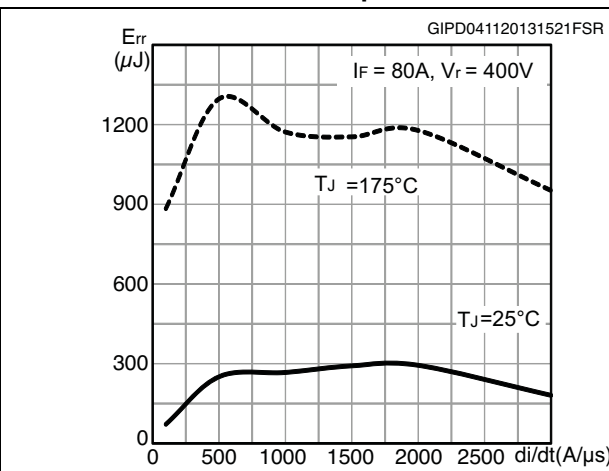


Figure 26. Thermal impedance for IGBT

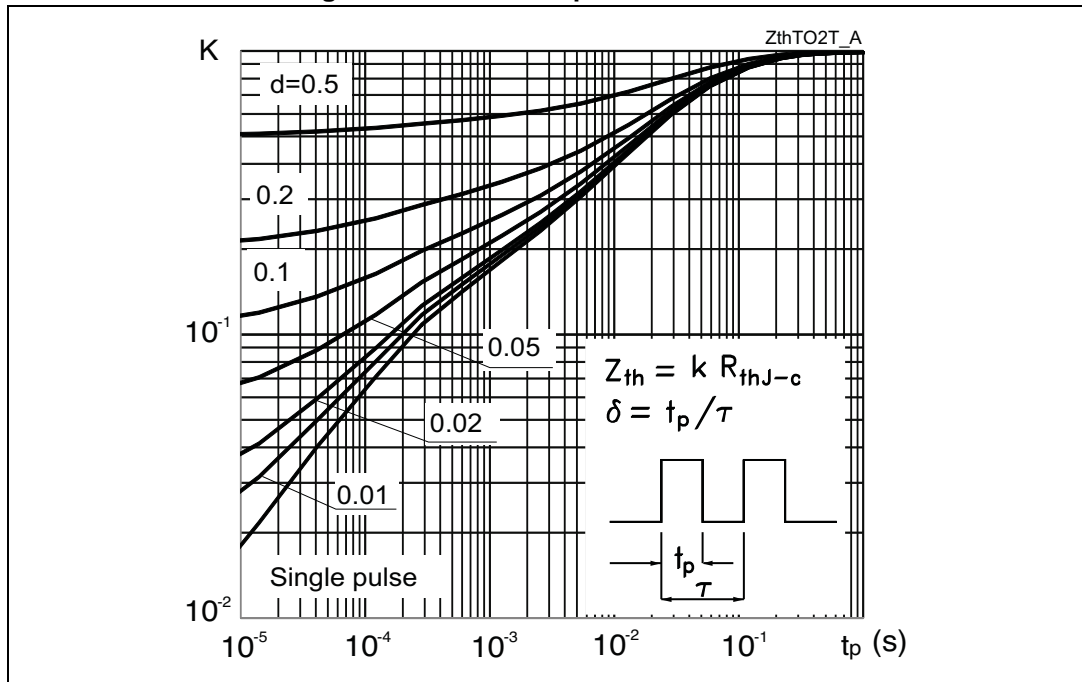
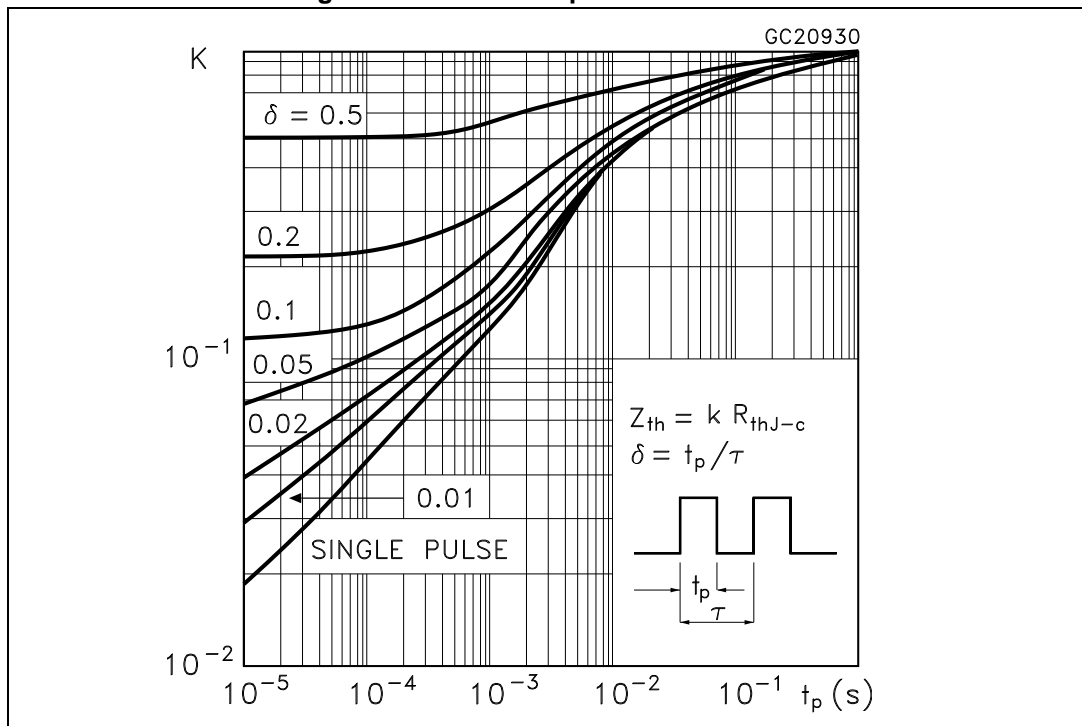


Figure 27. Thermal impedance for diode



### 3 Test circuits

Figure 28. Test circuit for inductive load switching

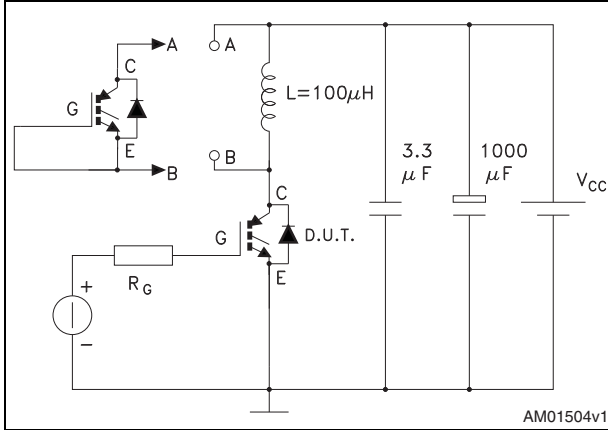


Figure 29. Gate charge test circuit

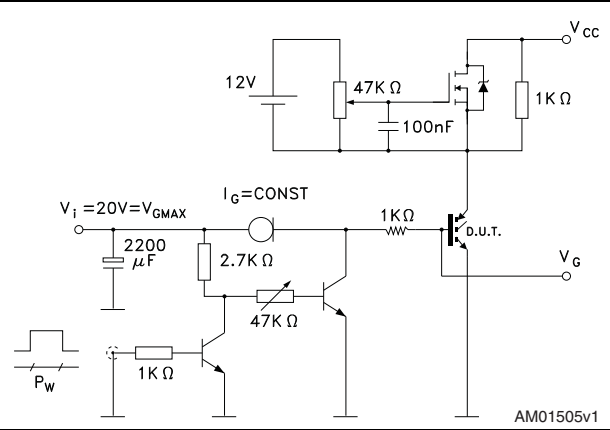


Figure 30. Switching waveform

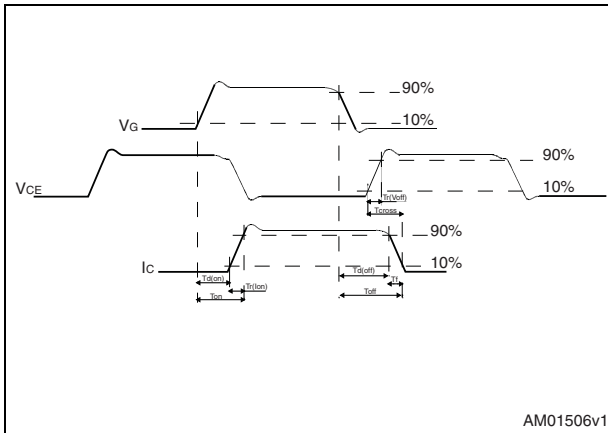
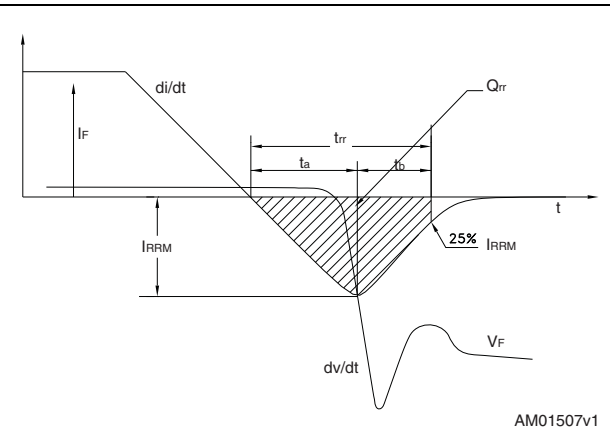


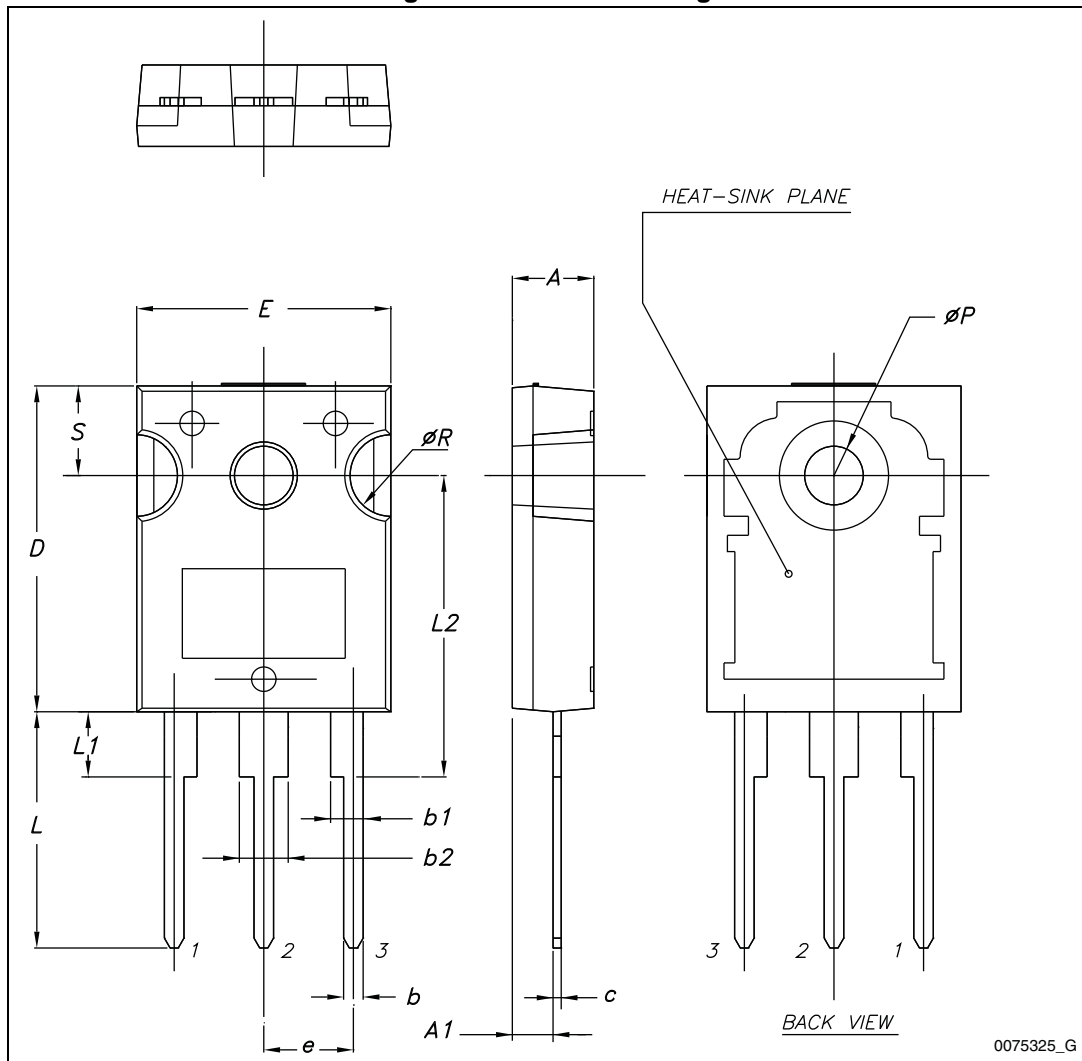
Figure 31. Diode recovery time waveform



## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

Figure 32. TO-247 drawing



0075325\_G

Table 8. TO-247 mechanical data

Dim.	mm.		
	Min.	Typ.	Max.
A	4.85		5.15
A1	2.20		2.60
b	1.0		1.40

Table 8. TO-247 mechanical data

Dim.	mm.		
	Min.	Typ.	Max.
b1	2.0		2.40
b2	3.0		3.40
c	0.40		0.80
D	19.85		20.15
E	15.45		15.75
e	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

Figure 33. TO-3P drawing

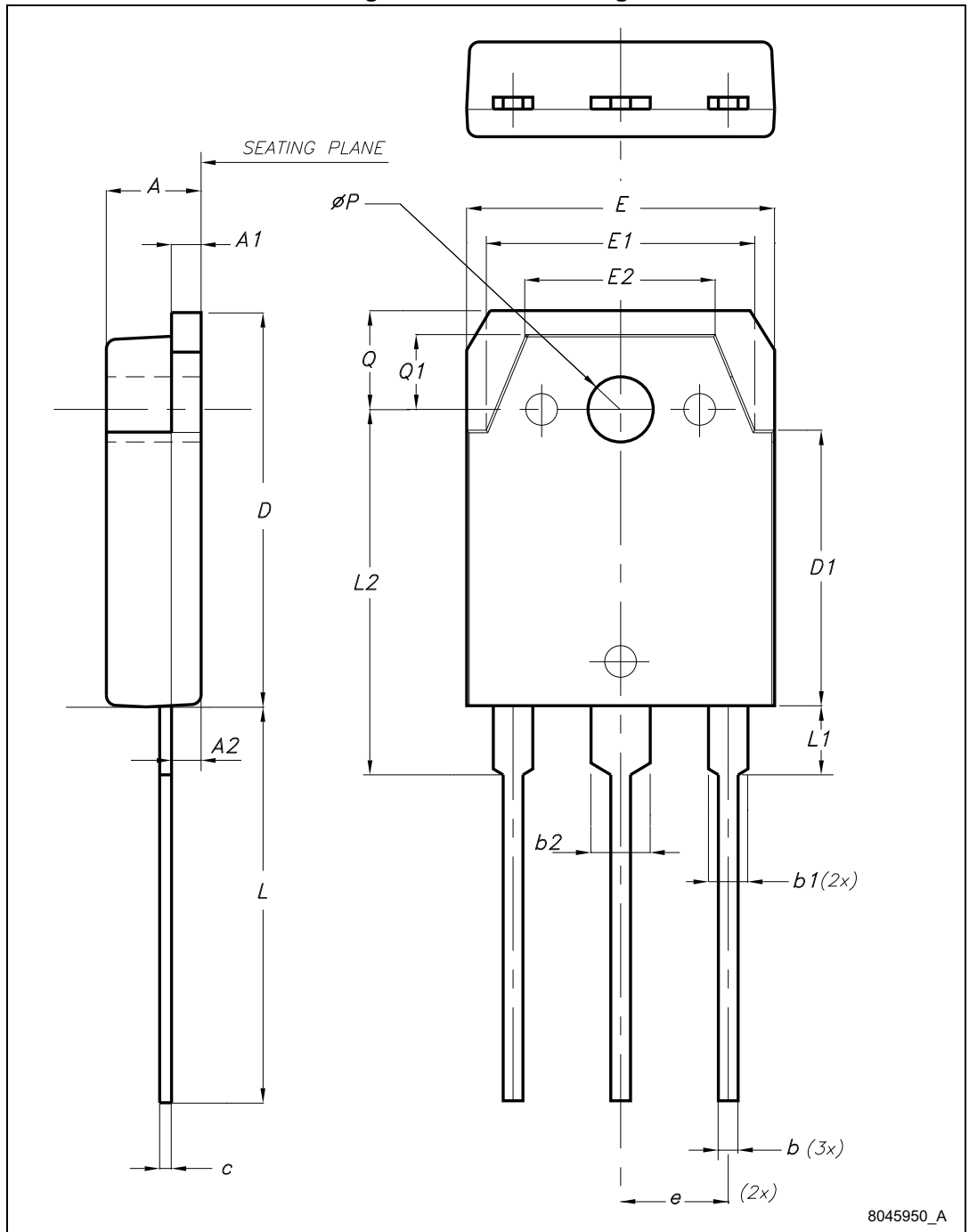


Table 9. TO-3P mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.60		5
A1	1.45	1.50	1.65
A2	1.20	1.40	1.60
b	0.80	1	1.20
b1	1.80		2.20
b2	2.80		3.20
c	0.55	0.60	0.75
D	19.70	19.90	20.10
D1		13.90	
E	15.40		15.80
E1		13.60	
E2		9.60	
e	5.15	5.45	5.75
L	19.50	20	20.50
L1		3.50	
L2	18.20	18.40	18.60
øP	3.10		3.30
Q		5	
Q1		3.80	

## 5 Revision history

Table 10. Document revision history

Date	Revision	Changes
12-Mar-2013	1	Initial release.
10-Jan-2014	2	Updated title, features and description in cover page. Document status promoted from preliminary to production data. Updated <a href="#">Table 4: Static characteristics</a> , <a href="#">Table 5: Dynamic characteristics</a> , <a href="#">Table 6: IGBT switching characteristics (inductive load)</a> and <a href="#">Table 7: Diode switching characteristics (inductive load)</a> . Inserted <a href="#">Section 2.1: Electrical characteristics (curves)</a> .

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